## Notice of References Cited

Application/Control No. 10/807,455	Applicant(s)/Patent Under Reexamination CHONAN ET AL.		
Examiner	Art Unit		
David D. Le	3681	Page 1 of 1	

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-4,504,247	03-1985	Chana et al.	474/17
	В	US-6,755,090 B2	06-2004	lma, Akihiro	74/330
	C	US-2005/0119076 A1	06-2005	Chonan et al.	474/029
	٥	US-4,458,318	07-1984	Smit et al.	701/51
	Е	US-4,602,525	07-1986	Moroto et al.	475/210
	F	US-6,875,152 B2	04-2005	lwatuki et al.	477/44
	G	US-4,392,394	07-1983	Hofbauer et al.	475/204
	I	US-4,560,369	12-1985	Hattori, Torao	474/28
	-	US-4,304,150	12-1981	Lupo et al.	475/51
	J	US-6,902,502 B2	06-2005	Murakami et al.	474/23
	Κ	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 04285354 A	10-1992	Japan	MORISAWA, KUNIO	F16H 37/02
	0					
	Р					
	ď					
	R					
	s					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.